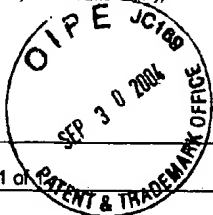


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PTO/SB/09A(10-01)
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US Patent & Trademark Office: U.S. DEPARTMENT OF COMMERCE

Complete if Known

Application Number	09/816,602
Filing Date	March 23, 2001
First Named Inventor	Jenson, Mark L.
Group Art Unit	1746
Examiner Name	Crepeau, Jonathan

Attorney Docket No: 1327.010US1

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Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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J. G.

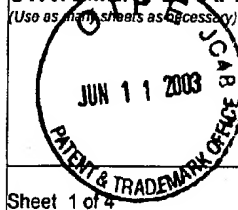
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PTO/SB/06A(10-01)
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 US Patent & Trademark Office U.S. DEPARTMENT OF COMMERCE

Complete if Known	
Application Number	09/816602
Filing Date	March 23, 2001
First Named Inventor	Jensen, Mark
Group Art Unit	1745
Examiner Name	Winter, Gentle
Attorney Docket No: 1327.010US1	

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DATE CONSIDERED 7/7/03

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Electronic Information Disclosure Statement

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GROUP 170

DEVICE ENCLOSURES AND DEVICES WITH INTEGRATED BATTERY

Application:



09/816602

Confirmation: 6174

Applicant(s): Mark Jensen

Docket

1327.010US1

Number:

Group Art

1745

Unit:

Examiner:

Unknown,Unknown

search string:

(US-4,299,890 or US-4,333,808 or US-4,365,107 or US-4,730,383 or US-4,740,431 or US-5,051,274 or US-5,151,848 or US-5,171,413 or US-5,180,645 or US-5,189,550 or US-5,192,947 or US-5,338,625 or US-5,411,592 or US-5,425,966 or US-5,426,561 or US-5,445,906 or US-5,448,110 or US-5,468,521 or US-5,549,989 or US-5,558,953 or US-5,571,749 or US-5,626,976 or US-5,644,207 or US-5,695,885 or US-5,763,058 or US-5,872,080 or US-5,978,207 or US-6,094,292 or US-6,222,117 or US-6,236,061).pn.

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Signature

Examiner Name	Date
	761 4/4/03

Form 1449*	Atty. Docket No.: 1327.010US1	Serial No. Unknown
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Applicant: Mark Lynn Jenson et al.	
	Filing Date: Herewith	Group: Unknown

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09/816602
03/23/01

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**Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
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